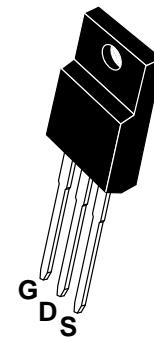


4.2Amps, 900Volts N-Channel MOSFET

PIN Connection TO-220F



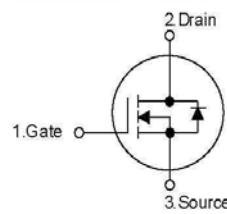
Description

The FIR4N90 N-Channel enhancement mode silicon gate power MOSFET is designed for high voltage, high speed power switching applications such as switching regulators, switching converters, solenoid, motor drivers, relay drivers

Features

- $R_{DS(ON)} = 3.1\Omega @ V_{GS} = 10\text{ V}$
- Low gate charge (typical 24nC)
- High ruggedness
- Fast switching capability
- Avalanche energy specified
- Improved dv/dt capability

Inner Equivalent Principium Chart



Marking Diagram



Y = Year
 A = Assembly Location
 WW = Work Week
 FIR4N90F = Specific Device Code

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$, unless otherwise specified)

Parameter		Symbol	Ratings	Units
Drain-Source Voltage		V_{DSS}	900	V
Gate-Source Voltage		V_{GSS}	± 30	V
Drain Currentet Continuous	$T_c=25^\circ\text{C}$	I_D	2.5*	A
	$T_c=100^\circ\text{C}$		1.58	A
Drain Current Pulsed (Note 1)		I_{DP}	10*	A
Avalanche Energy	Repetitive (Note 1)	E_{AR}	4.7	mJ
	Single Pulse (Note 2)	E_{AS}	570	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.0	V/ns
Total Power Dissipation	$T_c=25^\circ\text{C}$	P_D	47	W
	Derate above 25°C		0.38	W/ $^\circ\text{C}$
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55~+150	$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Termal Characteristics

Parameter	Symbol	Ratings	Units
Thermal Resistance Junction-Ambient	R_{thJA}	62.5	°C/W
Thermal Resistance, Case-to-Sink Typ.	R_{thCS}	--	
Thermal Resistance Junction-Case	R_{thJC}	2.66	

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless Otherwise specified.)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	900	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=900\text{V}, V_{GS}=0\text{V}$	--	--	10	μA
		$V_{DS}=720\text{V}, T_C=125^\circ\text{C}$	--	--	100	μA
Gate-Body Leakage Current	Forward Reverse	I_{GSS}	$V_{GS}=30\text{V}, V_{DS}=0\text{V}$	--	100	nA
			$V_{GS}=-30\text{V}, V_{DS}=0\text{V}$	--	-100	nA
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	$I_D=250\mu\text{A}$	--	0.90	--	V/ $^\circ\text{C}$
On Characteristics						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	3.0	--	5.0	V
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	$V_{DS}=10\text{V}, I_D=2.4\text{A}$	--	2.5	3.1	Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	860	1100	pF
Output Capacitance	C_{OSS}		--	90	120	pF
Reverse Transfer Capacitance	C_{RSS}		--	9.5	12.5	pF
Switching Characteristics						
Turn-On Delay Time	$t_{D(\text{ON})}$	$V_{DD}=450\text{V}, I_D=4.2\text{A}, R_G=25\Omega$ (Note 4, 5)	--	25	60	ns
Rise Time	t_R		--	70	150	ns
Turn-Off Delay Time	$t_{D(\text{OFF})}$		--	45	100	ns
Fall Time	t_F		--	40	90	ns
Total Gate Charge	Q_G	$V_{DS}=720\text{V}, I_D=4.2\text{A}$ $V_{GS}=10\text{V}$ (Note 4, 5)	--	24	30	nC
Gate-Source Charge	Q_{GS}		--	5.8	--	nC
Gate-Drain Charge	Q_{GD}		--	11.5	--	nC
Drain-Source Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0\text{V}, I_{SD}=4.2\text{A}$	--	--	1.4	V
Continuous Drain-Source Current	I_{SD}		--	--	4.2	A
Pulsed Drain-Source Current	I_{SM}		--	--	16.8	A
Reverse Recovery Time	t_{RR}	$V_{GS}=0\text{V}, I_{SD}=4.2\text{A}, dI_{SD}/dt=100\text{A}/\mu\text{s}$ (Note 4)	--	440	--	ns
Reverse Recovery Charge	Q_{RR}		--	3.3	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L=61 mH, $I_{AS} = 4.2\text{A}$, $V_{DD} = 50\text{V}$, $R_G=25\Omega$, Starting $TJ=25^\circ\text{C}$
3. $I_{SD}\leq 4.2\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD}\leq BV_{DSS}$, Starting $TJ=25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

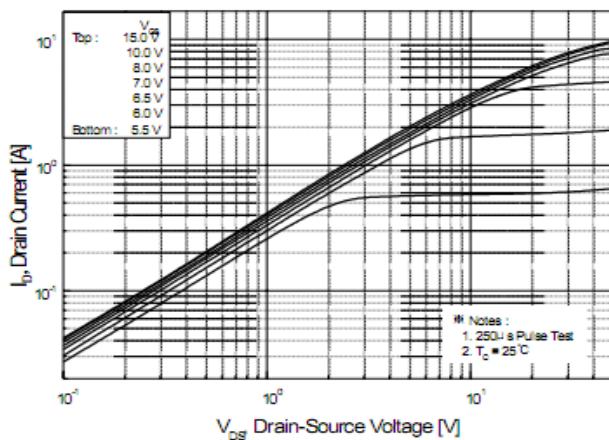


Figure 1. On-Region Characteristics

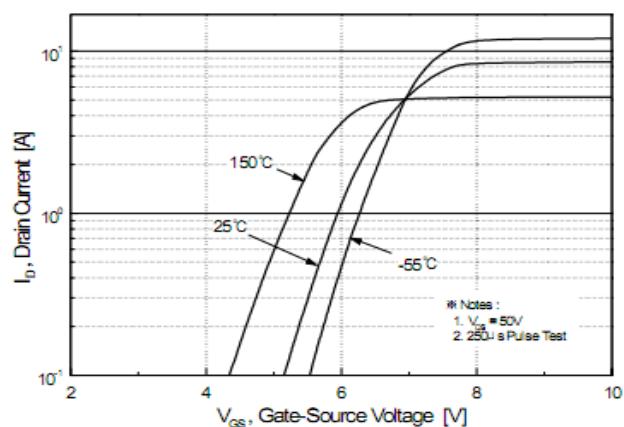


Figure 2. Transfer Characteristics

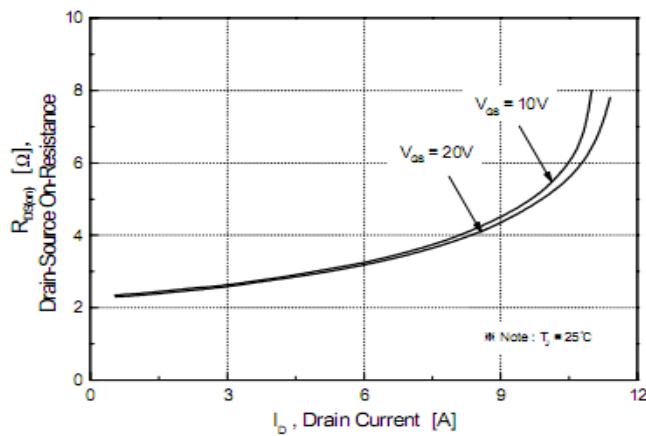


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

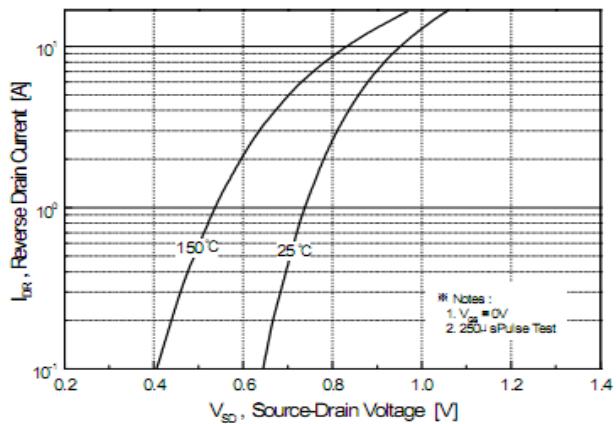


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

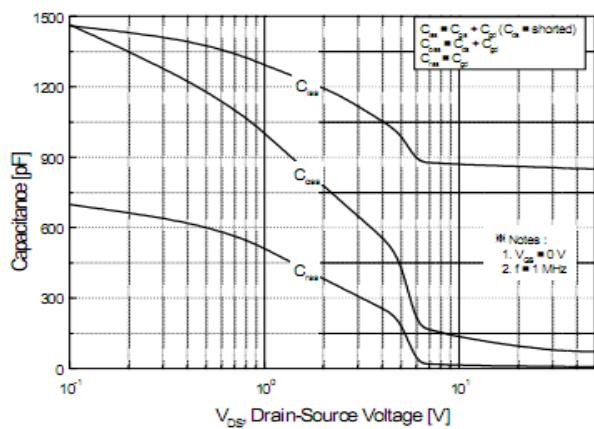


Figure 5. Capacitance Characteristics

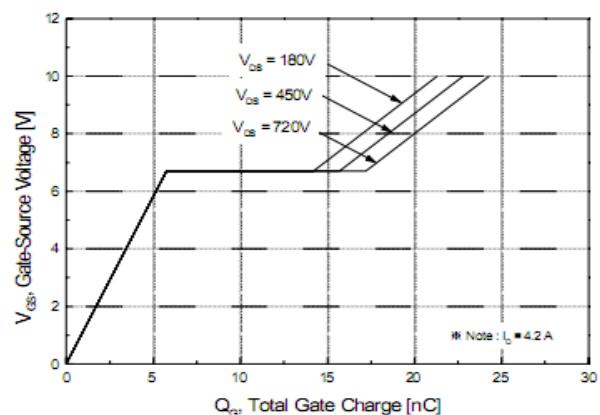
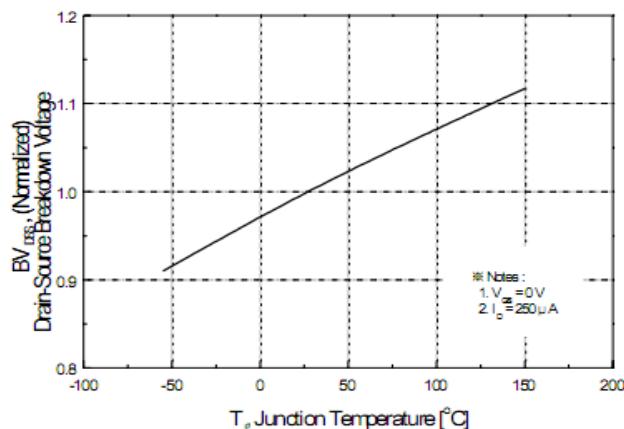
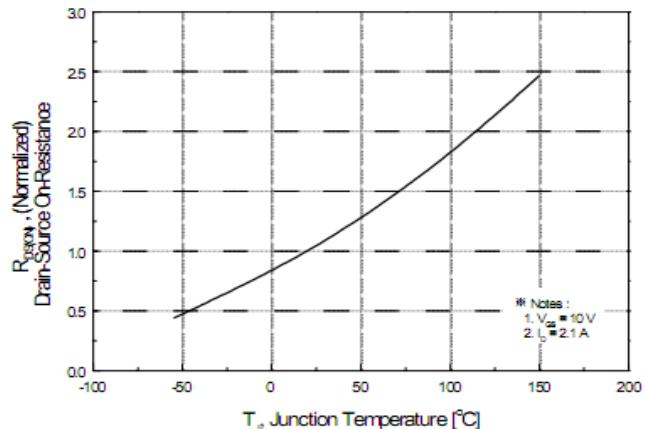


Figure 6. Gate Charge Characteristics

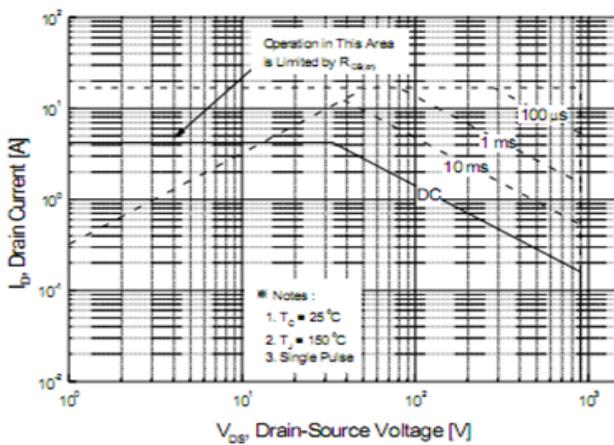
Typical Characteristics (Continued)



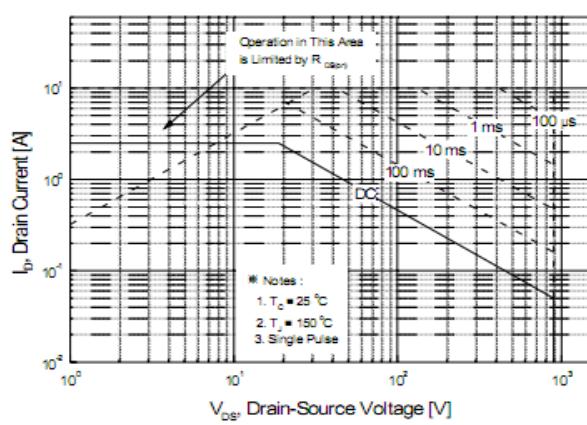
**Figure 7. Breakdown Voltage Variation
vs Temperature**



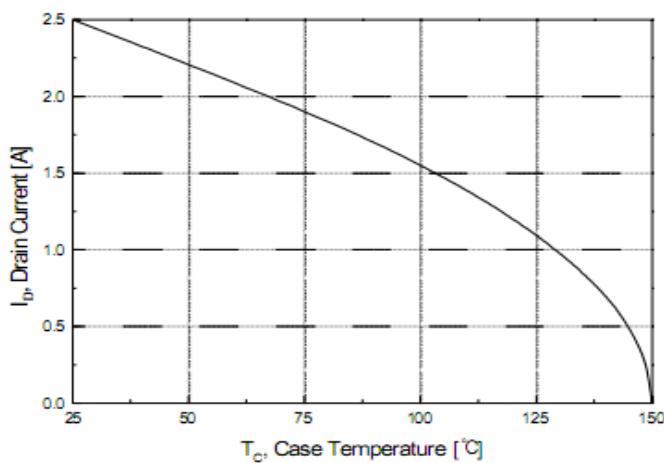
**Figure 8. On-Resistance Variation
vs Temperature**



**Figure 9-1. Maximum Safe Operating Area
for TO220**



**Figure 9-2. Maximum Safe Operating Area
for TO220F**



**Figure 10. Maximum Drain Current
vs Case Temperature**

Typical Characteristics (Continued)

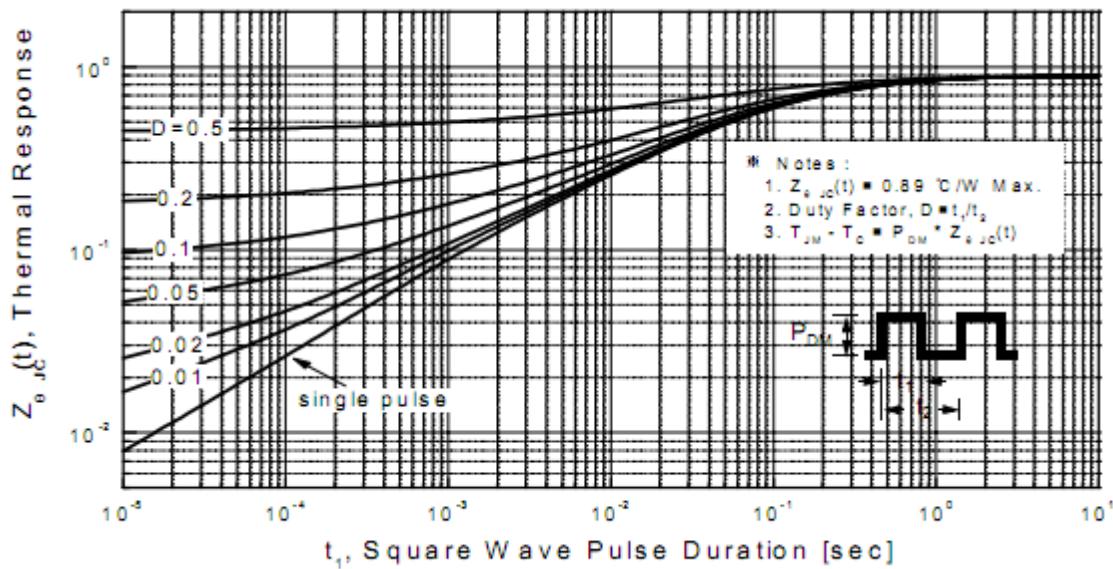


Figure 11-1. Transient Thermal Response Curve for 220

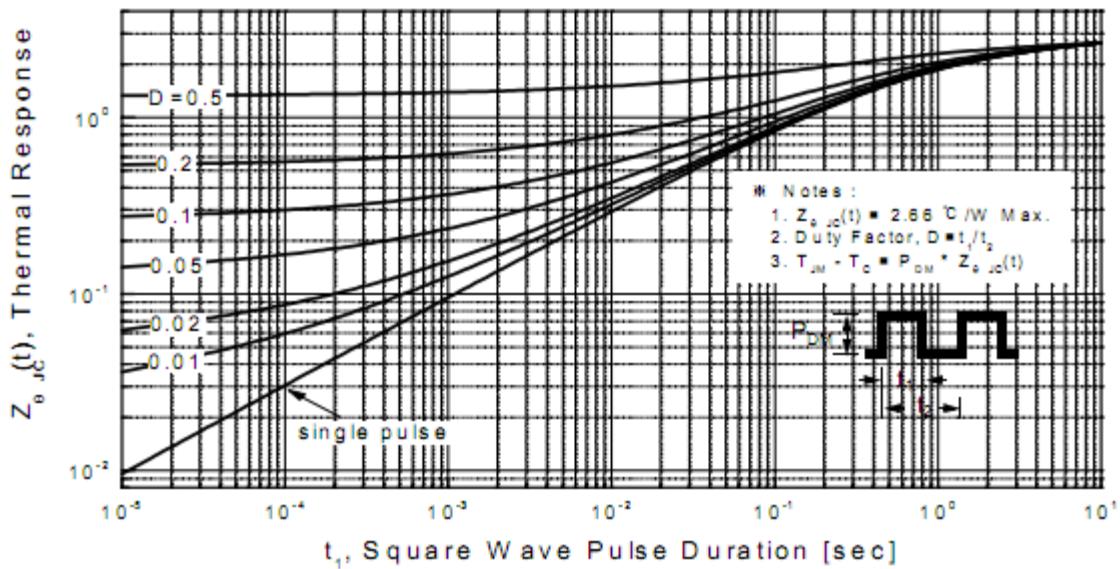
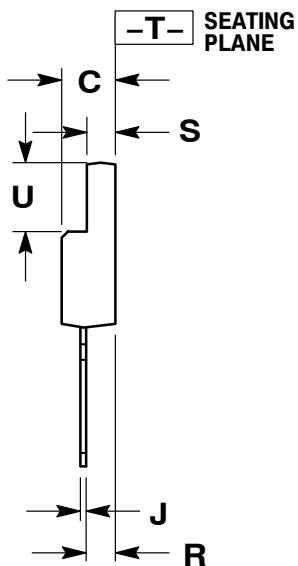
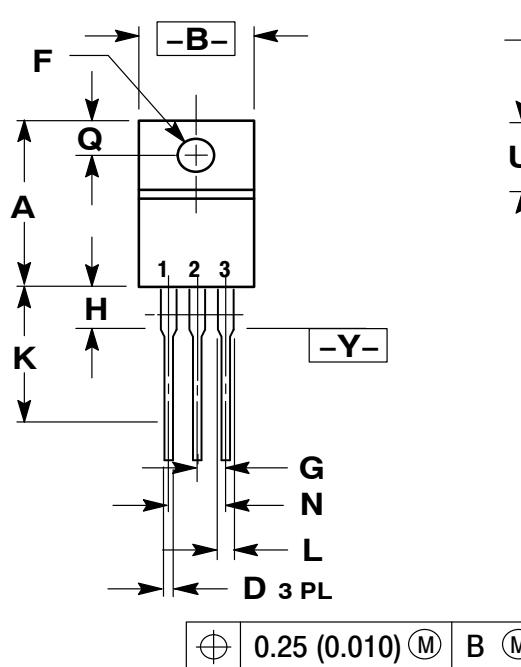


Figure 11-2. Transient Thermal Response Curve for TO220F

Package Dimensions

TO-220F



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH
3. 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.617	0.635	15.67	16.12
B	0.392	0.419	9.96	10.63
C	0.177	0.193	4.50	4.90
D	0.024	0.039	0.60	1.00
F	0.116	0.129	2.95	3.28
G	0.100 BSC		2.54 BSC	
H	0.118	0.135	3.00	3.43
J	0.018	0.025	0.45	0.63
K	0.503	0.541	12.78	13.73
L	0.048	0.058	1.23	1.47
N	0.200 BSC		5.08 BSC	
Q	0.122	0.138	3.10	3.50
R	0.099	0.117	2.51	2.96
S	0.092	0.113	2.34	2.87
U	0.239	0.271	6.06	6.88